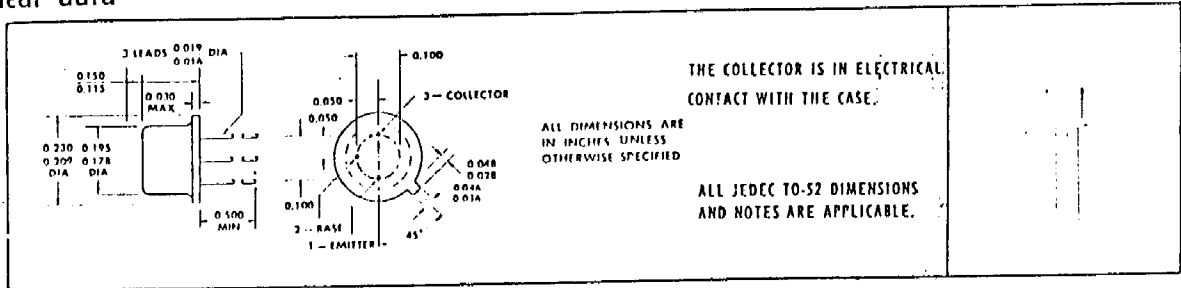


2N3829 PNP Silicon Transistor

*mechanical data



*absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)

Collector-Base Voltage	-35 v
Collector-Emitter Voltage (See Note 1)	-35 v
Collector-Emitter Voltage (See Note 2)	-20 v
Emitter-Base Voltage	-5 v
Continuous Collector Current	-200 ma
Peak Collector Current (See Note 3)	-500 ma
Continuous Device Dissipation at (or below) 25°C Free-Air Temperature (See Note 4)	360 mw
Continuous Device Dissipation at (or below) 25°C Case Temperature (See Note 5)	1.2 w
Storage Temperature Range	-65°C to +200°C
Lead Temperature 1/8 Inch from Case for 10 seconds	300°C

*electrical characteristics at 25°C free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT
$V_{(BR)CBO}$ Collector-Base Breakdown Voltage	$I_C = -100 \mu A, I_E = 0$	-35		v
$V_{(BR)CEO}$ Collector-Emitter Breakdown Voltage	$I_C = -10 \text{ ma}, I_B = 0$, See Note 6	-20		v
$V_{(BR)CES}$ Collector-Emitter Breakdown Voltage	$I_C = -100 \mu A, V_{BE} = 0$	-35		v
$V_{(BR)EBO}$ Emitter-Base Breakdown Voltage	$I_E = -100 \mu A, I_C = 0$	-5		v
I_{CES} Collector Cutoff Current	$V_{CE} = -20 \text{ v}, V_{BE} = 0$		-0.3	μA
	$V_{CE} = -20 \text{ v}, V_{BE} = 0, T_A = 125^\circ C$		-40	μA
I_B Base Current	$V_{CE} = -20 \text{ v}, V_{BE} = 0$		0.3	μA
h_{FE} Static Forward Current Transfer Ratio	$V_{CE} = -0.4 \text{ v}, I_C = -10 \text{ ma}$		25	
	$V_{CE} = -0.4 \text{ v}, I_C = -30 \text{ ma}$	See Note 6	30	120
	$V_{CE} = -1 \text{ v}, I_C = -100 \text{ ma}$		25	
	$V_{CE} = -0.4 \text{ v}, I_C = -30 \text{ ma}, T_A = -55^\circ C$		12	
V_{BE} Base-Emitter Voltage	$I_B = -1 \text{ ma}, I_C = -10 \text{ ma}$	See Note 6	-0.75	-0.85
	$I_B = -3 \text{ ma}, I_C = -30 \text{ ma}$		-0.75	-0.95
	$I_B = -10 \text{ ma}, I_C = -100 \text{ ma}$		-1.20	
$V_{CE(sat)}$ Collector-Emitter Saturation Voltage	$I_B = -1 \text{ ma}, I_C = -10 \text{ ma}$	See Note 6	-0.18	
	$I_B = -3 \text{ ma}, I_C = -30 \text{ ma}$		-0.18	
	$I_B = -10 \text{ ma}, I_C = -100 \text{ ma}$		-0.35	
	$I_B = -3 \text{ ma}, I_C = -30 \text{ ma}, T_A = 125^\circ C$		-0.25	

- NOTES: 1. This value applies when the base-emitter diode is short circuited.
 2. This value applies between 0 and 10 ma collector current when the base-emitter diode is open circuited.
 3. This value applies for $PW \leq 10 \mu sec, Duty Cycle \leq 40\%$.
 4. Derate linearly to 175°C free-air temperature at the rate of 2.4 mw/°C.
 5. Derate linearly to 175°C case temperature at the rate of 8 mw/°C.
 6. These parameters must be measured using pulse techniques. $PW = 300 \mu sec, Duty Cycle \leq 2\%$.

*Indicates JEDEC registered data.

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